

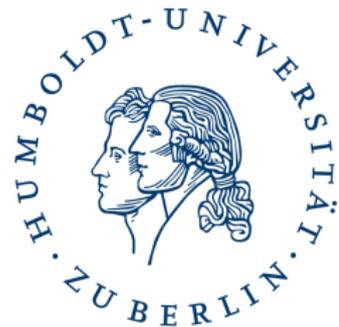
Search for 4th generation quarks with same-sign dilepton events in 4.7 fb^{-1} pp collisions at $\sqrt{s} = 7 \text{ TeV}$ with the ATLAS detector

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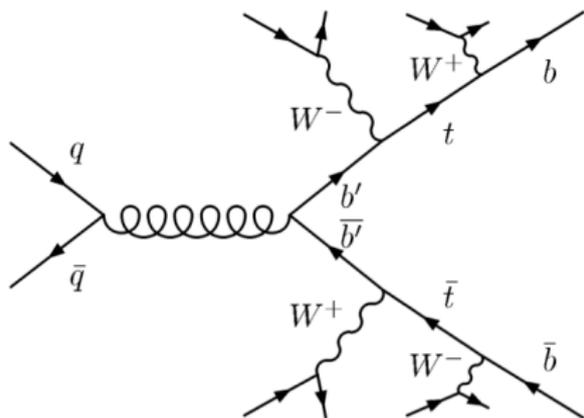
LHC BSM Parallel Session
Helmholtz Annual Workshop - Physics at the Terascale
03.12.2012



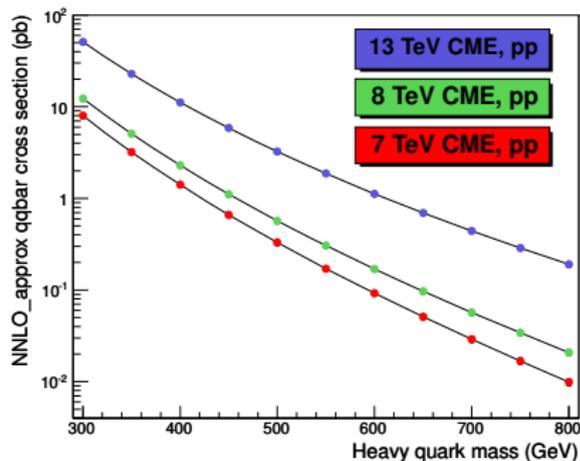
- 1 Introduction
 - Motivation
 - Strategy
 - Implications from Higgs searches
- 2 Backgrounds
 - MC and data-driven
- 3 Analysis (ATLAS-CONF-2012-130)
 - ATLAS detector
 - Object selection
 - Event selection
 - Control region distributions
 - Systematic uncertainties
 - Final event yields
 - Expected and observed limits
- 4 Summary

Fourth generation down-type quark (b')

- Looking for pair production of chiral 4th generation quarks as simple SM extension
- Consider decay: $b' \rightarrow tW^- \rightarrow bW^+W^-$ (100% BR)
- Could play interesting role in EW symmetry breaking
- Allows for gauge coupling unification in non-SUSY GUT



Production and decay



Production cross-section (HATHOR)
Comput.Phys.Comm.182:1034-1046,2011

- We study events with two same-sign charged leptons in the final state
 - ↔ rare SM signature
 - ↔ possible contributions from BSM physics

The considered decay $b' \rightarrow tW \rightarrow bWW$ leads to final states involving top quarks and can result in events with

- two same-sign charged leptons
- 2 or more jets (and b-jets)
- high \cancel{E}_T and H_T ($H_T = \sum P_T^{\text{Leptons}} + \sum P_T^{\text{Jets}}$)

- The analysis is performed on the **full 2011 data set** (4.7 fb^{-1})
- Part of CONF note (ATLAS-CONF-2012-130):
"Search for exotic same-sign dilepton signatures (b' quark, $T_{5/3}$ and 4-tops production) in 4.7 fb^{-1} of pp collisions at $\sqrt{s} = 7 \text{ TeV}$ with the ATLAS detector"

Implications from Higgs searches

- Within SM4: would observe
 - different Higgs decay BF
 - higher Higgs production cross section in gluon fusion (factor ≈ 9)

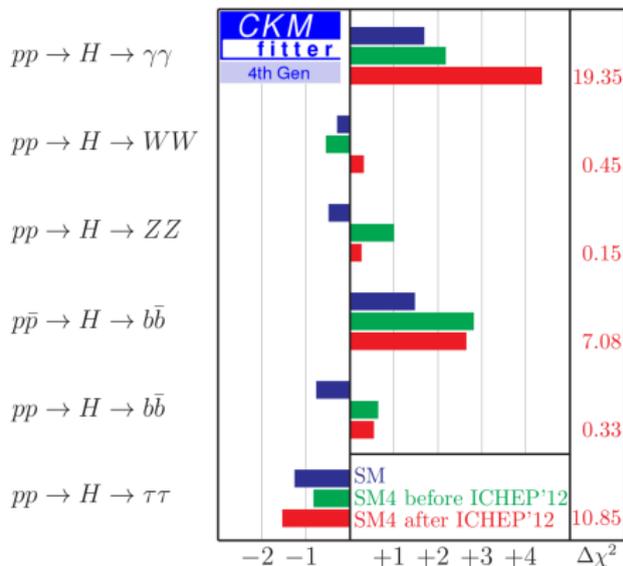
- $\hat{\mu}_{\text{exp/fit}}$:
Measured/fitted signal strength assuming SM3 or SM4 (before/after ICHEP12)

• Shown: $\left[\frac{\hat{\mu}_{\text{exp}} - \hat{\mu}_{\text{fit}}}{\Delta \hat{\mu}_{\text{exp}}} \right]$

- All channels combined:
SM4 excluded at 5.3σ !

Search topology still interesting

- 4th generation still possible with other models, e.g. 2-Higgs doublet
- VLQ has similar topology
→ same search strategy



arXiv:1209.1101 (accepted by PRL)

Background processes with same-sign dileptons in the final state:

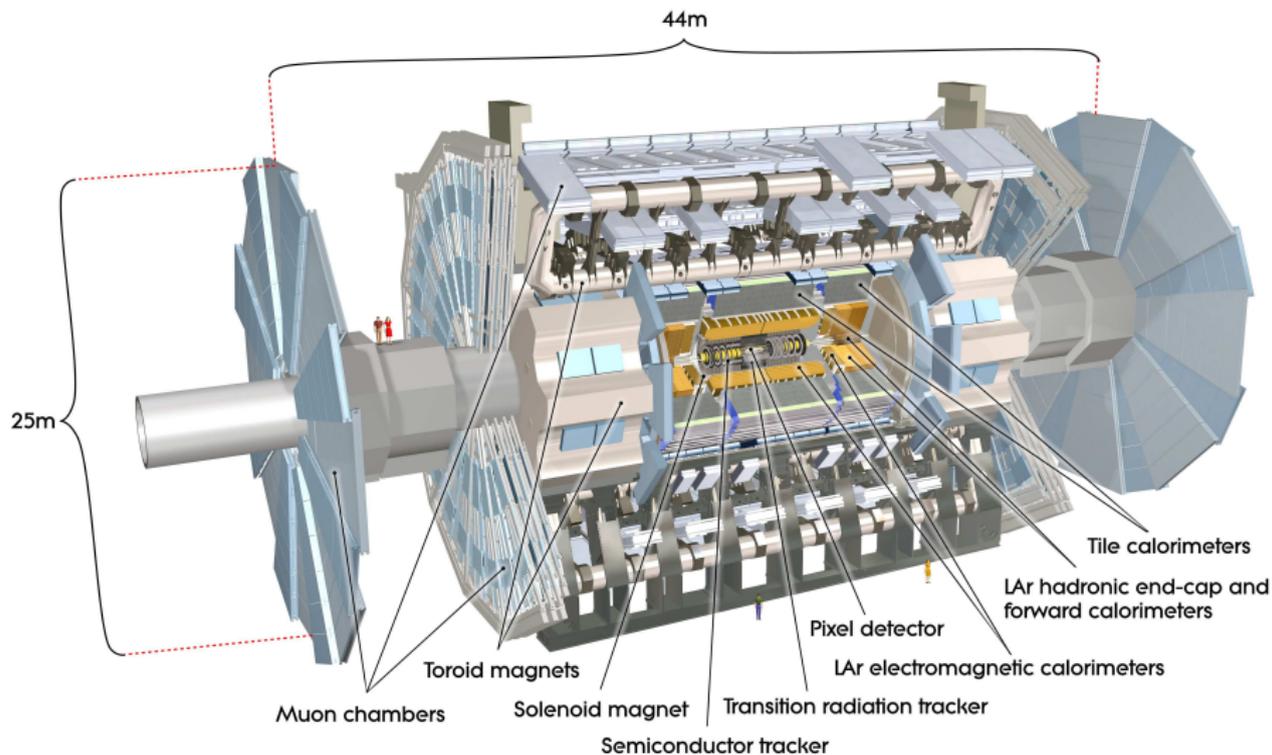
Irreducible backgrounds (MC)

- Diboson WZ/ZZ +jets (AlpGen)
- Diboson $W^\pm W^\pm$ +jj (MadGraph)
- $t\bar{t} + W(+j)$, $t\bar{t} + Z(+j)$, $t\bar{t} + WW$ (MadGraph)

Charge Misd and lepton fakes (data-driven)

- Electron charge mis-identification (Charge Misd)
 - measuring Charge Misd rate in same-sign events within Z-peak
 - reweight OS events and treat as SS
- Lepton mis-reconstruction (Fakes)
 - using "matrix-method"
 - measuring fake efficiencies in fake enriched control regions

→ more information in backup



Electrons

- $p_t > 25 \text{ GeV}$
- $0 < \eta < 2.47$, excluding $1.37 < |\eta| < 1.52$
- Cluster based reconstruction algorithm
- Reject electrons with $\Delta R(e, jet) < 0.4$
- Isolated
- Recalibration + smearing

Muons

- $p_t > 20 \text{ GeV}$ and $|\eta| < 2.5$
- Combined muon (ID+MS)
- Reject cosmic muons
- Remove muons with $\Delta R(\mu, jet) < 0.4$
- Isolated
- Smearing

Jets

- Anti- k_T Topo jets ($\Delta R = 0.4$)
- $p_t > 25 \text{ GeV}$ and $|\eta| < 2.5$
- Remove the closest jet to an accepted electron.
- Recalibration (+ smearing for MC).

Event preselection

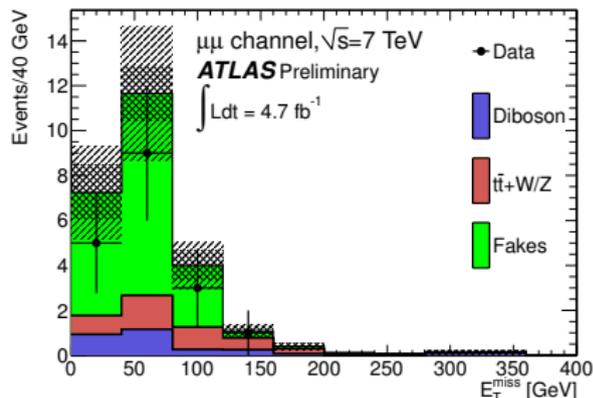
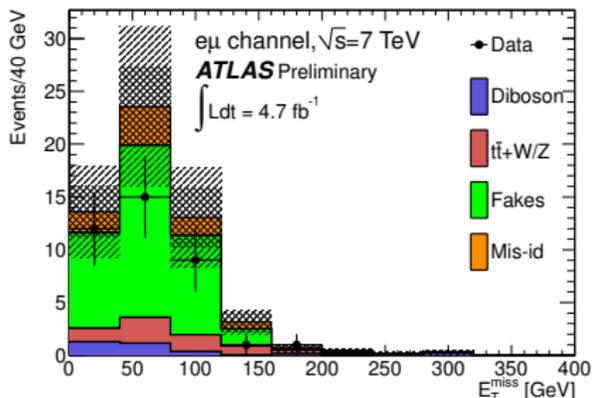
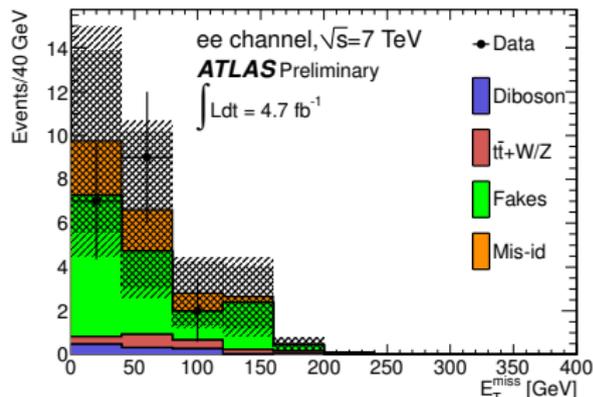
- Single lepton trigger & Good Run List (data)
- Primary vertex with at least 5 tracks ($P_T \geq 400$ MeV)
- Cosmic rejection and e/μ overlap rejection
- Invariant mass ($ee/\mu\mu$ events)
 - Z-veto: $|m_{inv} - m_Z| > 10$ GeV
 - $m_{inv} \geq 15$ GeV
- At least one trigger match

Additional selection (optimized, based on expected limit)

- At least two same-sign leptons, one with $P_T \geq 25$ GeV
 - Classification ($ee/e\mu/\mu\mu$) based on highest P_T pair
- $\cancel{E}_T \geq 40$ GeV, $H_T \geq 550$ GeV ($H_T = \sum P_T^e + P_T^\mu + P_T^{\text{Jets}}$)
- $N_{\text{Jets}} \geq 2$, $N_{\text{bJets}} \geq 1$ (b-tagging)

Control region

- Same-sign dileptons
- Event preselection
- No H_T cut
- No \cancel{E}_T cut
- $N_{\text{Jets}} \geq 2, N_{\text{bJets}} \geq 1$



Considered systematics

- Electrons: energy scale/resolution, SF ($< 5\%$)
 - Muons: energy scale/resolution, SF ($< 4\%$)
 - Jets: JES ($< 16\%$), JER, reco eff., JVF SF, b-tag SF ($< 5\%$)
 - \cancel{E}_T : Cell, PileUp ($< 1\%$)
-
- Luminosity: 3.7%
 - Diboson (WZ/ZZ+jets) cross-section: 34%
 - $W^\pm W^\pm + 2\text{jets}$ cross-section: 50%
 - $t\bar{t} + W + j$ cross-section: 30%
 - $t\bar{t} + Z + j$ cross-section: 50%
 - $t\bar{t} + WW$ cross-section: $+35\% / -24\%$
-
- b' cross-section: HATHOR ($< 20\%$)
 - PDF: $+1\% / -0.9\%$ estimated from reweighting method
 - Parton shower: 6% estimated from More/Less PS samples
-
- Lepton fakes: $50\%/40\%/30\%$ ($ee/e\mu/\mu\mu$)
 - QMisld: 12% estimated from difference between QMisld methods yields

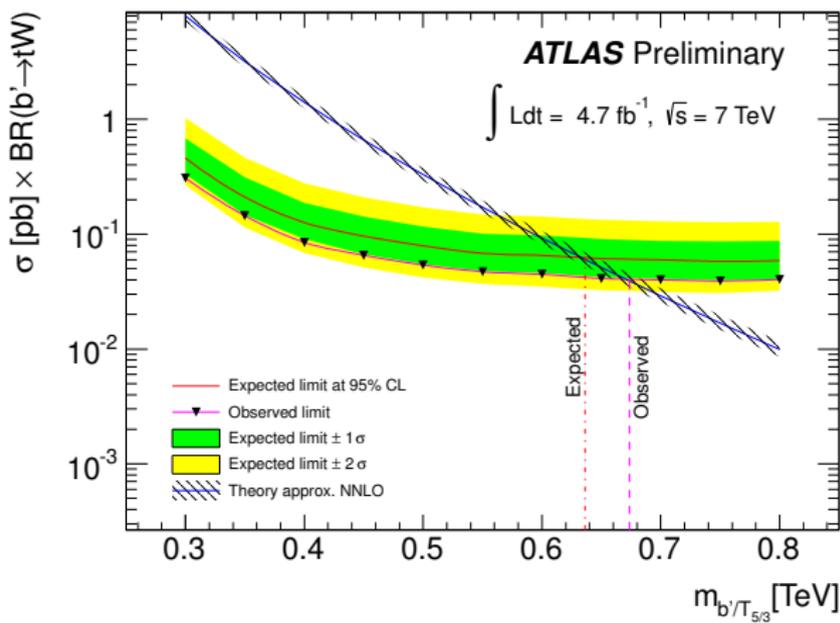
Expected yields and observed data in signal region

Samples	Channel		
	ee	$e\mu$	$\mu\mu$
Mis-id	$0.13 \pm 0.04 \pm 0.02$	$0.23 \pm 0.04 \pm 0.03$	—
Fakes	$0.52 \pm 1.12 \pm 0.26$	$0.82 \pm 1.05 \pm 0.33$	$0.13 \pm 0.13 \pm 0.04$
Diboson			
• WZ/ZZ +jets	$0.19 \pm 0.20 \pm 0.07$	$0.34 \pm 0.21 \pm 0.13$	$0.28 \pm 0.22 \pm 0.10$
• $W^\pm W^\pm$ +jj	$0.06 \pm 0.03 \pm 0.03$	$0.07 \pm 0.03 \pm 0.03$	$0.03 \pm 0.02 \pm 0.03$
$t\bar{t} + W/Z$			
• $t\bar{t}W$ (+jet)	$0.23 \pm 0.02 \pm 0.07$	$0.79 \pm 0.04 \pm 0.24$	$0.57 \pm 0.04 \pm 0.18$
• $t\bar{t}Z$ (+jet)	$0.17 \pm 0.02 \pm 0.09$	$0.61 \pm 0.03 \pm 0.31$	$0.33 \pm 0.02 \pm 0.17$
• $t\bar{t}W^\pm W^\mp$	$0.008 \pm 0.001 \pm 0.002$	$0.023 \pm 0.001 \pm 0.007$	$0.016 \pm 0.001 \pm 0.005$
Total	$1.31 \pm 1.14 \pm 0.29$	$2.88 \pm 1.07 \pm 0.53$	$1.36 \pm 0.26 \pm 0.27$
b' (600 GeV)	1.78 ± 0.08	5.09 ± 0.14	3.29 ± 0.11
Observed	2	2	0

- Uncertainties shown (BG): yield \pm stat. \pm syst.
- Uncertainties shown (Signals): yield \pm stat.

Limit determination

- CL_S method implemented in *MCLimit* (*Nucl.Instrum.Meth.* A434,435 (1999))
- Event yields from cut and count as input



$$m_{b'} \geq 0.67 \text{ TeV (expected: } m_{b'} \geq 0.64 \text{ TeV)}$$

Summary

- Presented search for 4th generation b' quarks in same-sign dilepton final states
- Assuming decay $b' \rightarrow tW$ (100% BR)
- Using 2011 data set ($\mathcal{L} = 4.7 \text{ fb}^{-1}$) at 7 TeV
- Observed no excess \rightarrow setting limit on b' mass:
Expected: $m \geq 0.64 \text{ TeV}$, **Observed $m \geq 0.67 \text{ TeV}$**
- Analysis with 2012 data set has started

CONF note: ATLAS-CONF-2012-130

Backup slides

Charge mis-identification

Estimated by measuring the **charge misidentification rate ϵ** reconstructing a Z peak using 2 same-sign electrons in data.

- ϵ is computed as a **function of $|\eta|$** bins for three different methods:

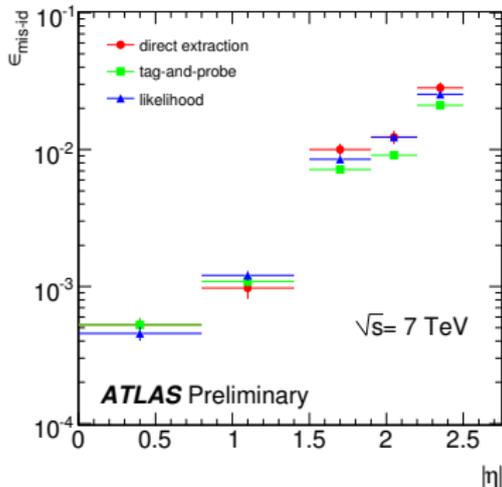
- 1 Tag and Probe method.
- 2 Direct extraction method.
- 3 Likelihood method.

- A **side-band** method is used for the background subtraction:

- The Z peak is divided in 3 parts: A, B, C on [61-81], [81-101] and [101-121] GeV.
- Background is estimated in the A and C regions and interpolated to the region B.

- The **number of signal events** is

$$N_B^S = N_B - (N_A + N_C)/2$$



Differences on the rates comes from the kinematic selection

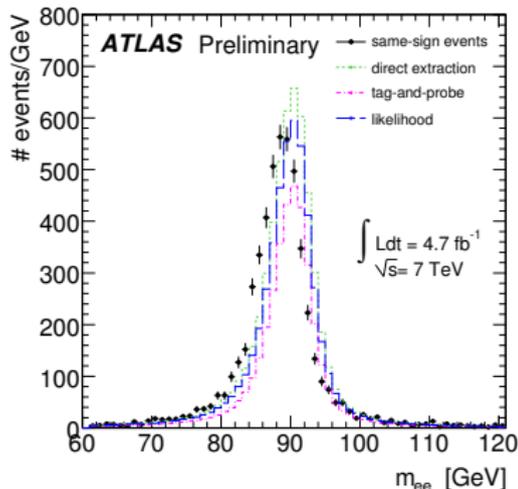
Charge mis-identification

- We take the $M_{e^+e^-}$ distribution for the opposite sign electrons.
- Each event is **weighted** with:

$$\omega(i, j) = \frac{\epsilon_i + \epsilon_j}{(1 - \epsilon_i)(1 - \epsilon_j)} \quad (1)$$

ϵ_i is the charge flip rate in the η bin i .

- The final same-sign distribution is obtained from $M_{e^+e^-}$ weighted with $\omega(i, j)$.
- Method validated by Egamma Working Group.
- **Likelihood method** is used to extract the event.
- The other two methods are used to compute the systematics.



Likelihood method gives the best agreement!

Lepton fakes

The **matrix method** is used to determine the magnitude of the mis-reconstructed leptons (from leptons or jets) in the dilepton signal regions.

- Electron and Muon **real** and **fake rates** are provided by LLMatrixMethodB and MuJetsMatrixMethodA from **Top Group FakeMacros tools**.

Two sets of leptons selection criteria are defined: **Loose** and **Tight** .

- **Electrons:**
 - **Loose:** isEM (MediumPP) + not match photons conversion + **isolation**.
 - **Tight:** Same definition than in the analysis.
- **Muons:**
 - **Loose:** TopCommon selection without muon isolation.
 - **Tight:** Same definition than in the analysis.

The **probabilities** r and f that a real or fake "Loose" lepton pass the "Tight" criteria is measured using purified control regions.

Lepton fakes

The composition of the signal samples is extracted by inverting the following matrix:

$$\begin{bmatrix} N_{TT} \\ N_{TL} \\ N_{LT} \\ N_{LL} \end{bmatrix} = \begin{bmatrix} rr & rf & fr & ff \\ r(1-r) & r(1-f) & f(1-r) & f(1-f) \\ (1-r)r & (1-r)f & (1-f)r & (1-f)f \\ (1-r)(1-r) & (1-r)(1-f) & (1-f)(1-r) & (1-f)(1-f) \end{bmatrix} \begin{bmatrix} N_{RR} \\ N_{RF} \\ N_{FR} \\ N_{FF} \end{bmatrix}$$

relating the "true" composition of the sample in terms of real and fake leptons to Tight and Loose leptons.

- **Electrons:** rates parametrized as a function of η and P_T of the electron.
- **Muons:** rates parametrized as a function of η of the muon and P_T of the leading jet.

Events that tend to have a charge misidentified electron (**trident electrons**) tend to also be identified as fakes in the matrix method:

The overlap between the charge misidentification and fakes ($\approx 22\%$) is measured, and this amount is used to rescale the final mis-id estimate.

Lepton fakes

- **Electrons rate:**

- **Signal efficiencies:** determined with a Tag & Probe $Z^0 \rightarrow ee$ method with same cleaning as for top studies + overlap removal procedure applied with Loose leptons.
- **Fakes efficiencies:** estimated in a sample with at least 1 jet ($P_T > 25$ GeV) and 1 Loose lepton + $\Delta R(\text{leading jet, lepton}) > 0.7$ + overlap removal performed with loose electrons + $\cancel{E}_T < 20$ GeV.

- **Muons rate:**

- **Signal efficiencies:** determined with a Tag & Probe $Z^0 \rightarrow \mu\mu$ method by selecting prompt muons from the Z decay.
- **Fake efficiencies:** determined from data in a low transverse W mass region with an inverted triangular cut $M_T(W) < 20$ GeV, $\cancel{E}_T + M_T(W) < 60$ GeV.

Cut optimisation

Starting with our preselection, we performed various studies to increase our sensitivity. We varied various parameters of our selection criteria with the goal of establishing a set of cuts that would give us strong expected limits for all signals.

- Optimised event selection cuts based on expected limit
- Investigated cuts on H_T and N_{Jets}

Event selection optimization

b' cut optimization

- Optimization based on expected mass limit
- Varied cuts on H_T and N_{Jets}
- Using full systematics in limit determination (listed later)

H_T [GeV] \ N_{Jets}	≥ 2	≥ 3	≥ 4	≥ 5
≥ 350	—	—	591.58	591.70
≥ 400	592.52	595.39	599.34	—
≥ 450	608.19	609.51	612.12	608.37
≥ 500	622.69	621.44	615.57	—
≥ 550	636.26	636.61	621.22	—
≥ 600	629.67	628.83	609.60	—
≥ 650	638.66	637.26	617.26	—

Expected b' mass limits in GeV
ATLAS work in progress

Summary of optimised cuts

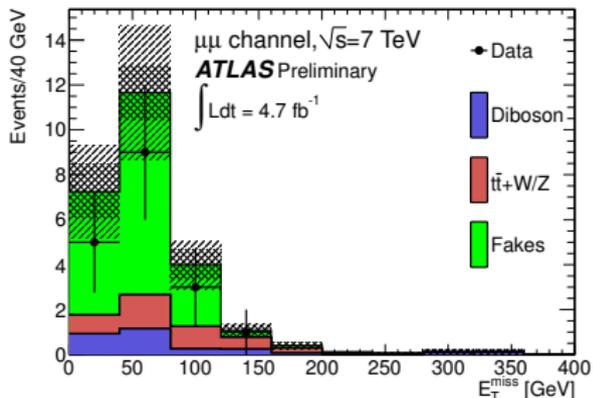
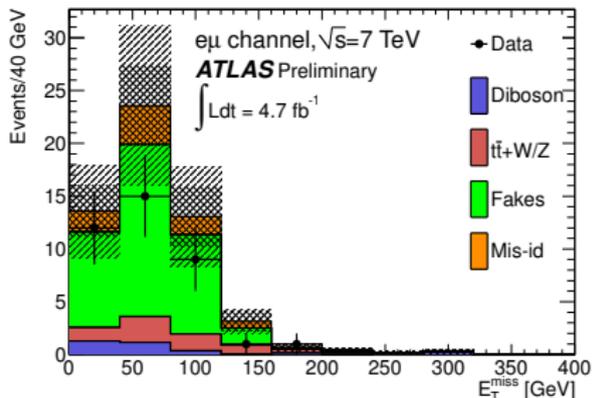
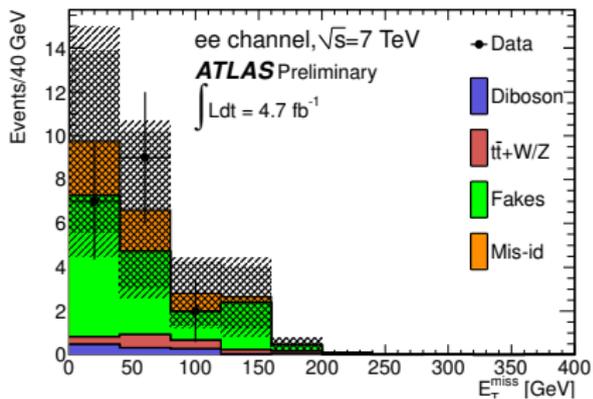
- $H_T \geq 550 \text{ GeV}$
- $N_{\text{Jets}} \geq 2$
- $N_{\text{bJets}} \geq 1$

Control region 1

- Event preselection
- Same-sign dileptons
- $N_{\text{Jets}} \geq 2$, $N_{\text{bJets}} \geq 1$
- No cut on H_T (Loosened relative to signal region)
- No cut on \cancel{E}_T (Loosened relative to signal region)

Control region 1

- Same-sign dileptons
- No H_T cut
- No \cancel{E}_T cut
- $N_{\text{Jets}} \geq 2$, $N_{\text{bJets}} \geq 1$

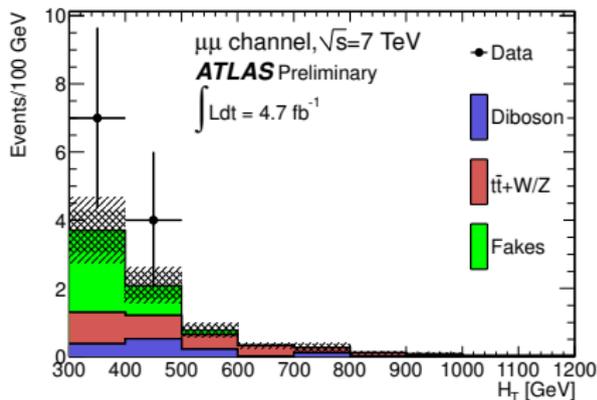
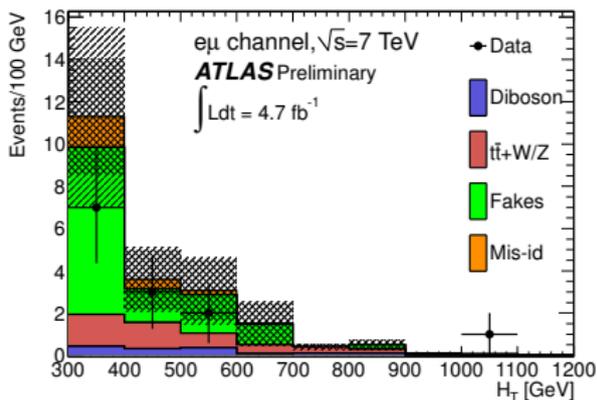
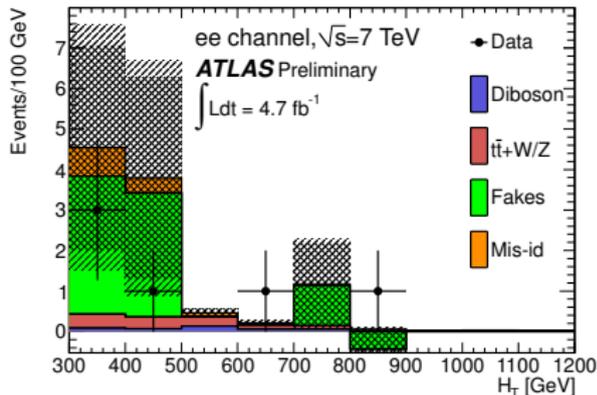


Control region 2

- Event preselection
- Same-sign dileptons
- $N_{\text{Jets}} \geq 2, N_{\text{bJets}} \geq 1$
- **No cut on H_T** (Loosened relative to signal region)
- $\cancel{E}_T \geq 40 \text{ GeV}$

Control region 2

- Same-sign dileptons
- No H_T cut
- $\cancel{E}_T \geq 40$ GeV
- $N_{\text{Jets}} \geq 2$, $N_{\text{bJets}} \geq 1$



Largest object systematics (Uncertainties in %)

Sys.	b' 500	550GeV $\lambda = 1$	FourTops	ttbar_W	ttbar_Z	ttbar_WW	WZ_ZZ	WWjj
<i>ee</i>								
JES	3.0/-4.8	2.2/-2.8	4.2/-1.4	9.3/-10.4	6.3/-7.7	3.2/-8.1	15.9/-14.4	6.0/-6.0
BJET	0.0/-1.6	0.8/-0.3	1.3/0.0	3.5/-3.8	1.7/-3.7	0.0/-2.1	0.0/0.0	0.0/-3.4
JVF	2.9/-2.9	2.9/-2.9	4.0/-3.9	2.6/-2.6	2.8/-2.7	2.9/-2.8	1.7/-1.7	1.7/-1.7
MuTSF	0.1/-0.2	0.2/-0.3	0.2/-0.3	0.1/-0.2	0.0/-0.1	0.1/-0.2	0.0/0.0	0.0/0.0
ElDSF	4.7/-4.7	4.7/-4.7	4.7/-4.7	4.7/-4.6	5.5/-5.4	4.7/-4.7	5.2/-5.1	4.5/-4.5
Others	2.2/2.6	2.3/2.2	3.7/2.3	3.1/4.9	2.9/2.6	2.7/2.6	3.6/3.4	2.0/2.0
<i>eμ</i>								
JES	3.4/-3.4	3.0/-2.7	0.8/-2.4	8.1/-8.8	10.8/-8.3	9.7/-8.0	13.4/-12.6	6.3/-7.9
BJET	0.7/-0.7	0.8/-1.0	1.0/-0.8	3.6/-2.6	1.9/-2.3	1.2/-1.5	0.0/0.0	0.0/0.0
JVF	3.0/-3.0	3.0/-2.9	4.0/-3.9	2.6/-2.5	2.7/-2.7	3.0/-2.9	1.6/-1.7	1.6/-1.6
MuTSF	1.5/-1.6	1.5/-1.6	1.4/-1.5	1.4/-1.5	1.6/-1.7	1.4/-1.5	1.8/-1.9	1.3/-1.4
ElDSF	2.4/-2.5	2.4/-2.5	2.4/-2.5	2.3/-2.4	2.8/-2.8	2.3/-2.4	2.8/-2.9	2.2/-2.3
Others	1.6/1.4	1.5/1.5	1.4/1.5	1.7/1.6	2.1/2.0	1.5/1.4	3.9/2.8	1.8/1.3
<i>$\mu\mu$</i>								
JES	2.2/-4.6	1.4/-1.3	0.0/-1.1	8.1/-9.9	5.4/-6.9	5.1/-4.0	6.0/-2.7	0.5/-10.9
BJET	0.0/-0.6	0.6/-0.8	0.0/-0.5	4.1/-0.9	1.8/-3.0	0.5/-1.8	0.0/0.0	0.0/0.0
JVF	2.9/-2.8	3.0/-3.0	4.0/-3.9	2.6/-2.6	2.6/-2.6	2.9/-2.9	1.7/-1.7	1.6/-1.6
MuTSF	2.8/-2.9	2.8/-2.8	2.8/-2.8	2.6/-2.7	3.4/-3.4	2.7/-2.7	3.5/-3.5	2.4/-2.5
ElDSF	0.2/-0.4	0.2/-0.3	0.1/-0.2	0.1/-0.2	0.0/-0.1	0.2/-0.3	0.0/0.0	0.0/0.0
Others	1.7/1.9	1.7/1.7	1.7/1.8	2.4/1.8	2.5/2.6	1.8/1.8	6.7/4.9	3.5/3.4

ATLAS work in progress

Expected b' yields

Expected signal yields

Signal parameter	Channel		
Mass [GeV]	ee	$e\mu$	$\mu\mu$
b' pair production			
300	16.75 ± 2.17	77.78 ± 4.97	57.84 ± 4.33
350	16.78 ± 1.44	64.50 ± 2.88	36.20 ± 2.21
400	12.30 ± 0.83	41.85 ± 1.54	28.19 ± 1.29
450	8.05 ± 0.46	26.18 ± 0.85	16.25 ± 0.66
500	4.72 ± 0.20	15.84 ± 0.38	9.71 ± 0.30
550	2.83 ± 0.14	8.88 ± 0.25	6.34 ± 0.22
600	1.78 ± 0.08	5.09 ± 0.14	3.29 ± 0.11
650	0.98 ± 0.04	3.06 ± 0.08	2.00 ± 0.07
700	0.57 ± 0.03	1.84 ± 0.05	1.15 ± 0.04
750	0.36 ± 0.02	1.07 ± 0.03	0.66 ± 0.02
800	0.20 ± 0.01	0.61 ± 0.02	0.39 ± 0.01

- Uncertainties due to Monte-Carlo statistics are shown.

Limit determination

- CL_S method implemented in *MCLimit*
- Most suitable for low statistics
- Log-likelihood ratio (LLR) as test-statistic:

$$LLR = -2 \ln \frac{L_{s+b}}{L_b}$$

- Generation of pseudo-experiments (PSE)
- Considering uncertainties:
 - statistical fluctuations according to Poisson statistics
 - Gaussian fluctuations describing effect of systematic uncertainties
- CL_{s+b} and CL_b defined by PSE with $LLR > LLR_{\text{exp/obs}}$
- Signal cross sections are excluded at 95%CL for which

$$CL_S = \frac{CL_{s+b}}{CL_b} < 0.05$$